Search Notes

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/758,224	MORIYAMA ET AL.	
	Examiner	Art Unit	
_	Anthony Fick	1753	

SEARCHED					
Class	Subclass	Date	Examiner		
136	205	7/31/2007	ADF		
136	200	1/17/8	LUV		
136	203	1/17/58	LVV		
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IN'	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
136	200-200	1/17/08	LVV		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See EAST search history	7/31/2007	ADF		
Inventor search	7/27/2007	ADF		
Consulted with Nam Nguyen	8/2/2007	ADF		
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